

OptiMOS® Power-Transistor

Features

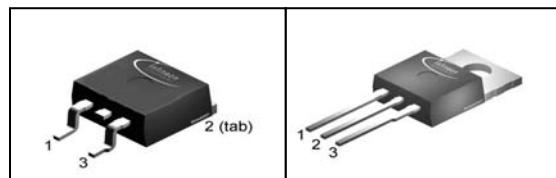
- N-channel Logic Level - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- **Green package (lead free)**
- Ultra low R_{ds(on)}
- 100% Avalanche tested

Product Summary

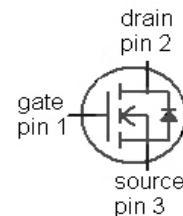
V_{DS}	55	V
$R_{DS(on),max}$ (SMD version)	6.7	mΩ
I_D	80	A

PG-T0263-3-2

PG-T0220-3-1



Type	Package	Ordering Code	Marking
IPB80N06S2L-07	PG-T0263-3-2	SP0002-18867	2N06L07
IPP80N06S2L-07	PG-T0220-3-1	SP0002-18831	2N06L07



Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ¹⁾	I_D	$T_C=25\text{ °C}$, $V_{GS}=10\text{ V}$	80	A
		$T_C=100\text{ °C}$, $V_{GS}=10\text{ V}^2)$	80	
Pulsed drain current ²⁾	$I_{D,pulse}$	$T_C=25\text{ °C}$	320	
Avalanche energy, single pulse ²⁾	E_{AS}	$I_D= 80\text{ A}$	450	mJ
Gate source voltage ⁴⁾	V_{GS}		±20	V
Power dissipation	P_{tot}	$T_C=25\text{ °C}$	210	W
Operating and storage temperature	T_j, T_{stg}		-55 ... +175	°C

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics²⁾

Thermal resistance, junction - case	R_{thJC}		-	-	0.7	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}		-	-	62	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ⁵⁾	-	-	40	

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0$ V, $I_D=1$ mA	55	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=150$ µA	1.2	1.6	2.0	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=55$ V, $V_{GS}=0$ V, $T_j=25$ °C	-	0.01	1	µA
		$V_{DS}=55$ V, $V_{GS}=0$ V, $T_j=125$ °C ²⁾	-	1	100	
Gate-source leakage current	I_{GSS}	$V_{GS}=20$ V, $V_{DS}=0$ V	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=4.5$ V, $I_D=60$ A	-	7.1	10	mΩ
		$V_{GS}=4.5$ V, $I_D=60$ A, SMD version	-	6.8	9.7	
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10$ V, $I_D=60$ A,	-	5.6	7.0	mΩ
		$V_{GS}=10$ V, $I_D=60$ A, SMD version	-	5.3	6.7	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics²⁾

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}$, $V_{DS}=25\text{ V}$, $f=1\text{ MHz}$	-	3160	-	pF
Output capacitance	C_{oss}		-	740	-	
Reverse transfer capacitance	C_{rss}		-	210	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=30\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=80\text{ A}$, $R_G=2\Omega$	-	18	-	ns
Rise time	t_r		-	35	-	
Turn-off delay time	$t_{d(off)}$		-	28	-	
Fall time	t_f		-	31	-	

Gate Charge Characteristics²⁾

Gate to source charge	Q_{gs}	$V_{DD}=44\text{ V}$, $I_D=80\text{ A}$, $V_{GS}=0$ to 10 V	-	11	14	nC
Gate to drain charge	Q_{gd}		-	32	48	
Gate charge total	Q_g		-	95	130	
Gate plateau voltage	$V_{plateau}$		-	3.5	-	

Reverse Diode

Diode continuous forward current ²⁾	I_S	$T_C=25\text{ }^\circ\text{C}$	-	-	80	A
Diode pulse current ²⁾	$I_{S,pulse}$		-	-	320	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}$, $I_F=80\text{ A}$, $T_j=25\text{ }^\circ\text{C}$	-	0.9	1.3	V
Reverse recovery time ²⁾	t_{rr}	$V_R=30\text{ V}$, $I_F=I_S$, $di_F/dt=100\text{ A}/\mu\text{s}$	-	59	75	ns
Reverse recovery charge ²⁾	Q_{rr}		-	80	100	

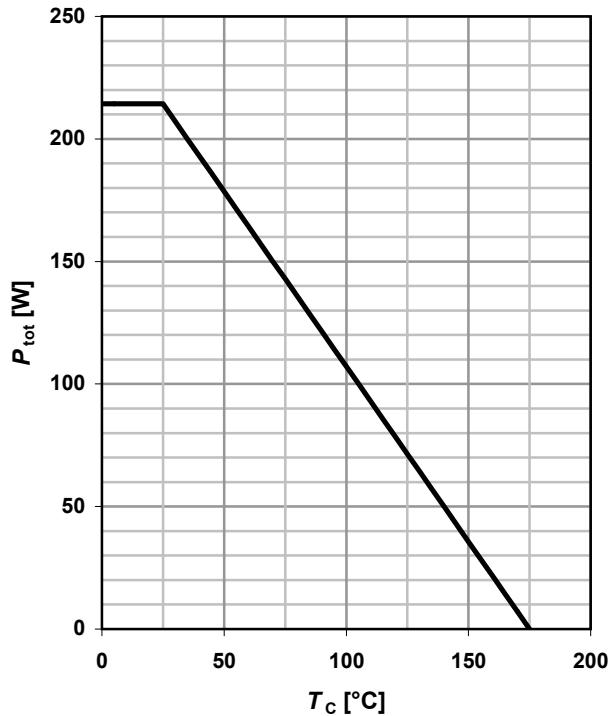
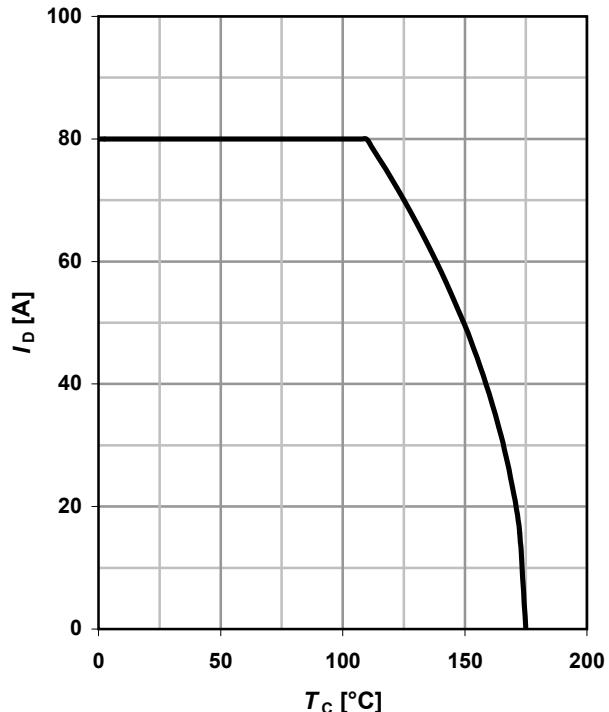
¹⁾ Current is limited by bondwire; with an $R_{thJC}=0.7\text{ K/W}$ the chip is able to carry 121 A at 25°C . For detailed information see Application Note ANPS071E at www.infineon.com/optimos

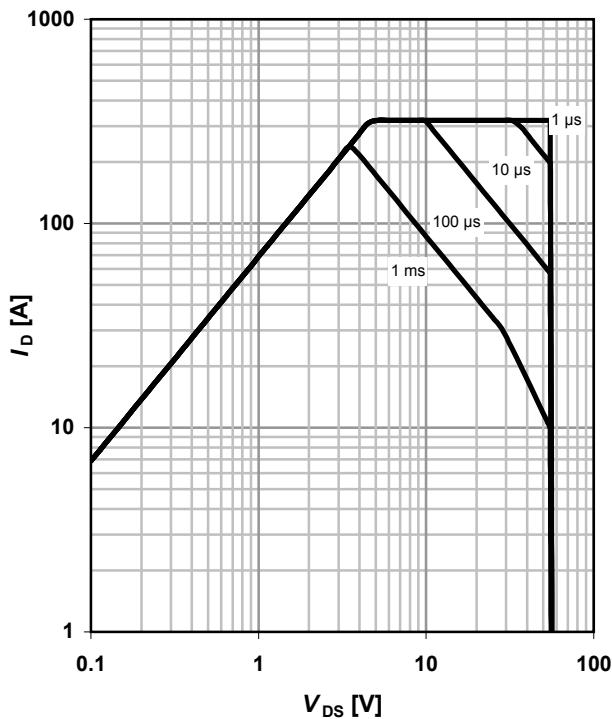
²⁾ Defined by design. Not subject to production test.

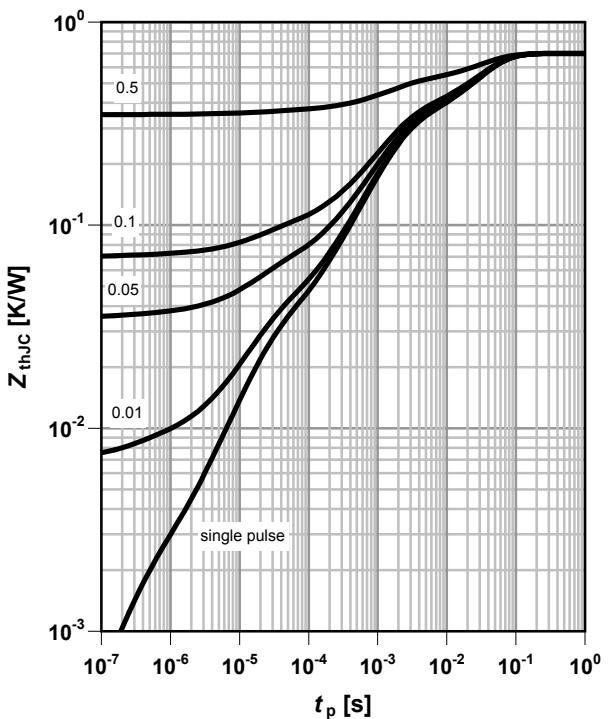
³⁾ See diagram 13

⁴⁾ Qualified at -20V and +20V.

⁵⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm^2 (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

1 Power dissipation
 $P_{\text{tot}} = f(T_c); V_{GS} \geq 4 \text{ V}$

2 Drain current
 $I_D = f(T_c); V_{GS} \geq 10 \text{ V}$

3 Safe operating area
 $I_D = f(V_{DS}); T_c = 25 \text{ °C}; D = 0$

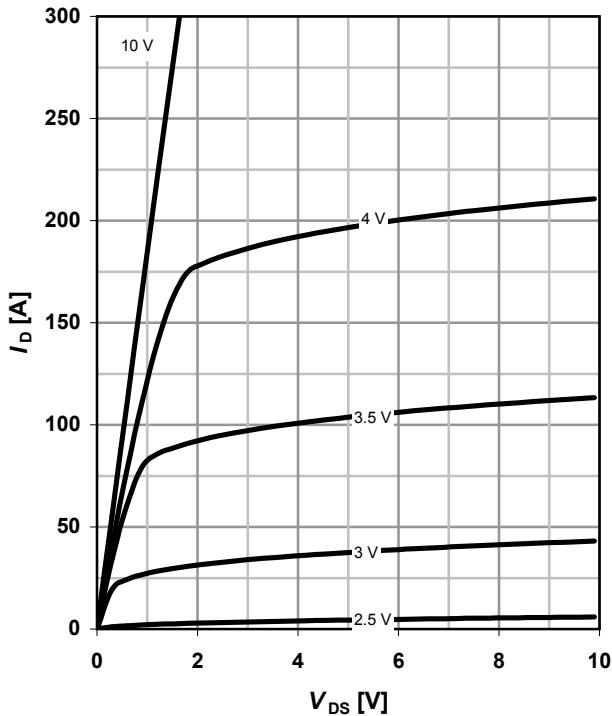
parameter: t_p

4 Max. transient thermal impedance
 $Z_{\text{thJC}} = f(t_p)$

parameter: $D = t_p/T$


5 Typ. output characteristics

$I_D = f(V_{DS})$; $T_j = 25^\circ\text{C}$

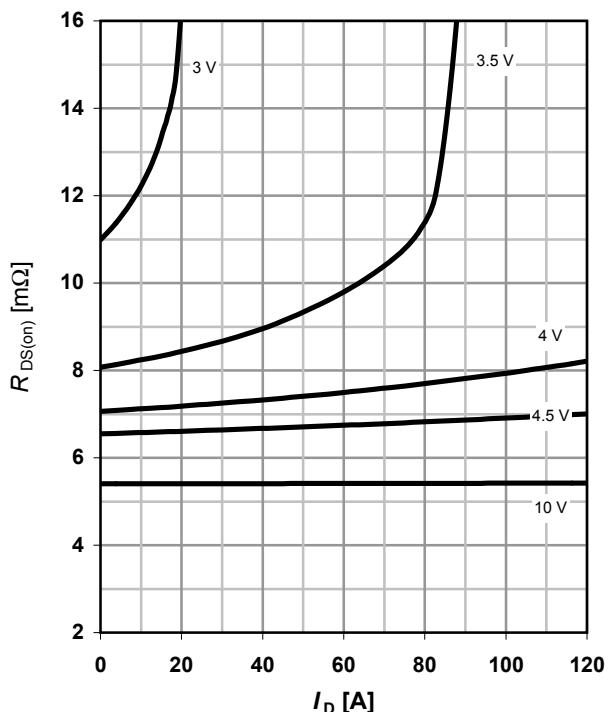
parameter: V_{GS}



6 Typ. drain-source on-state resistance

$R_{DS(on)} = (I_D)$; $T_j = 25^\circ\text{C}$

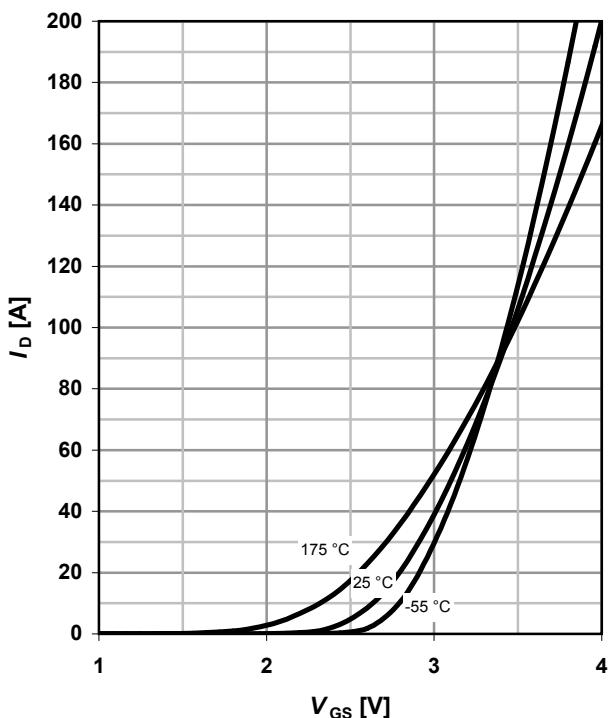
parameter: V_{GS}



7 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} = 6\text{V}$

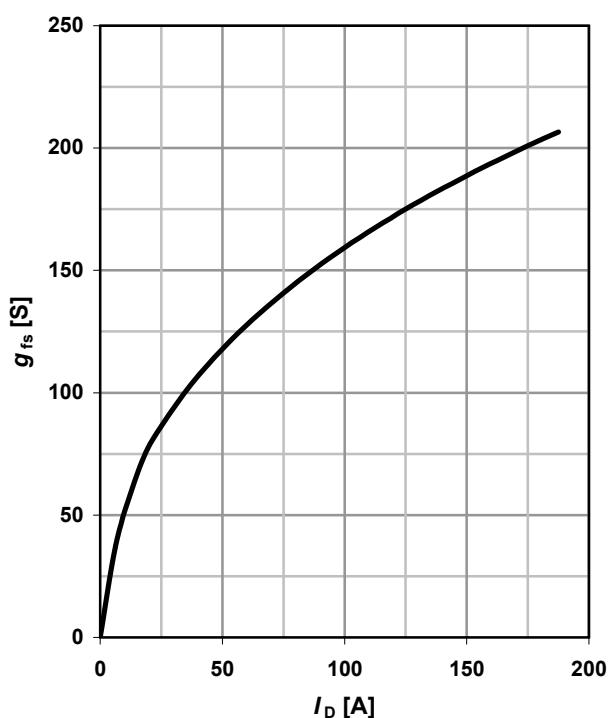
parameter: T_j



8 Typ. Forward transconductance

$g_{fs} = f(I_D)$; $T_j = 25^\circ\text{C}$

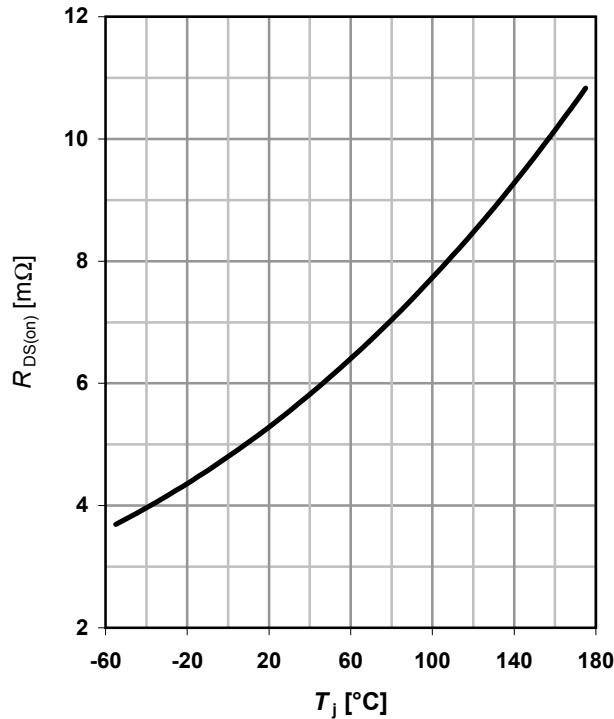
parameter: g_{fs}



9 Typ. Drain-source on-state resistance

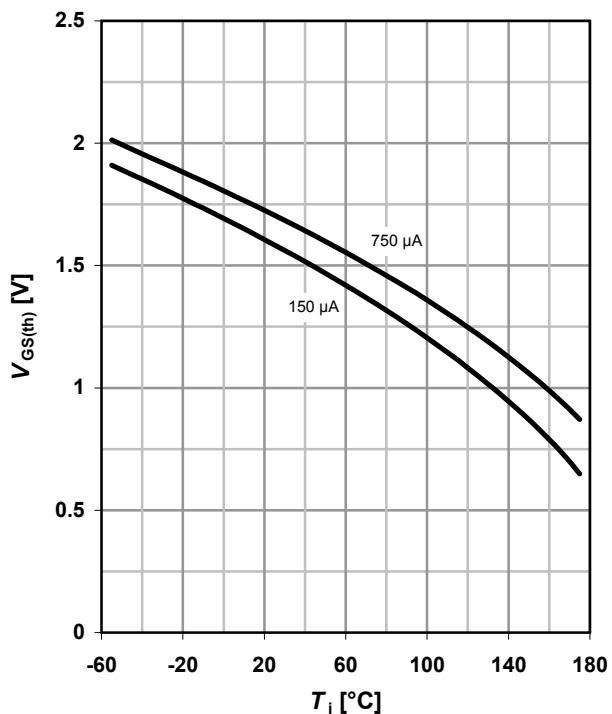
$$R_{DS(ON)} = f(T_j)$$

parameter: $I_D = 80 \text{ A}$; $V_{GS} = 10 \text{ V}$

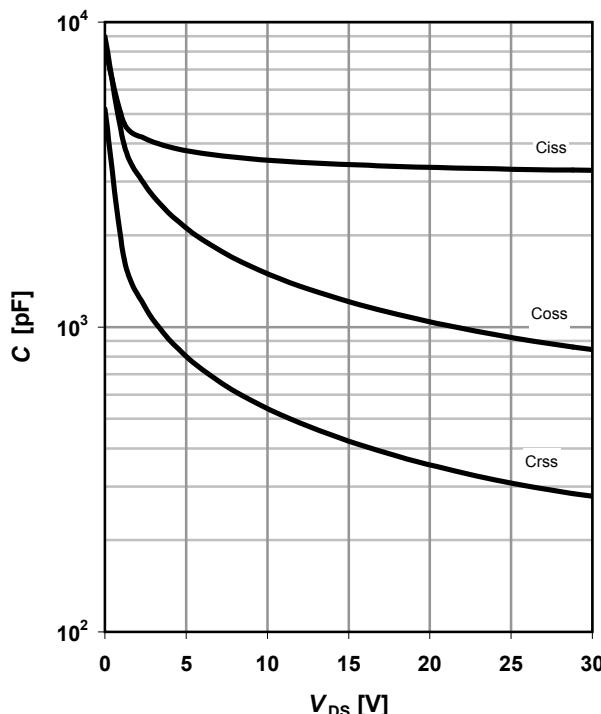

10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter: I_D

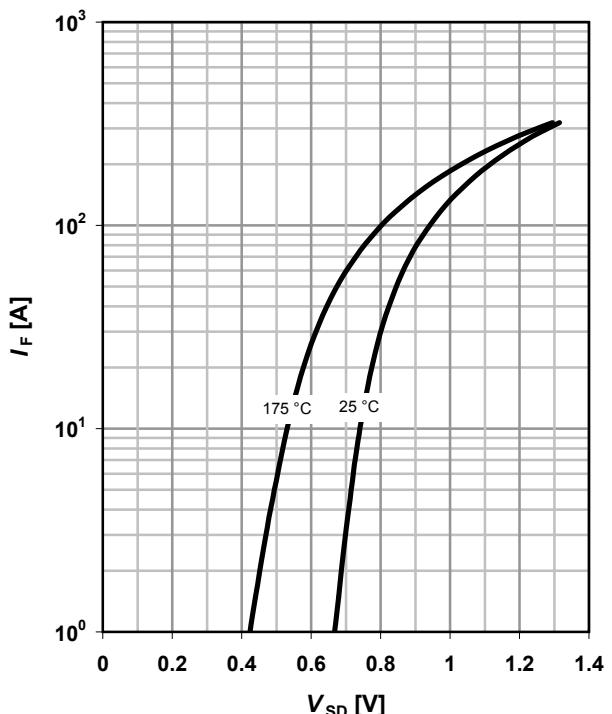

11 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$


12 Typical forward diode characteristicis

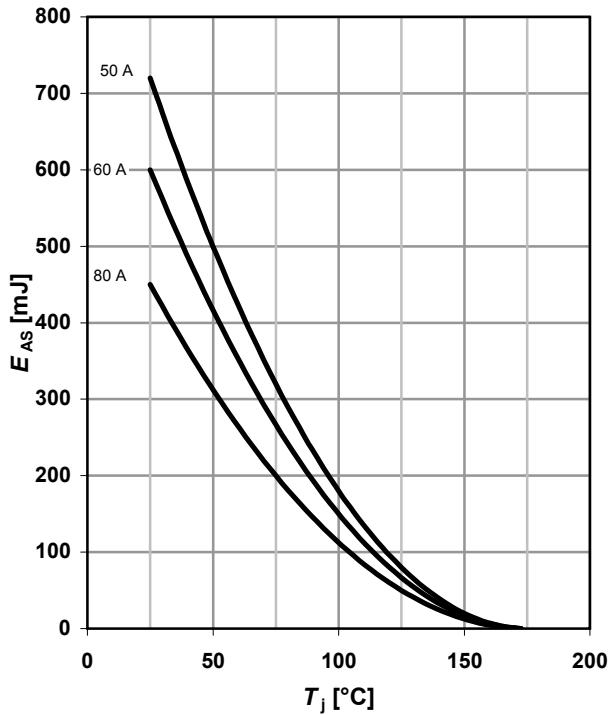
$$IF = f(V_{SD})$$

parameter: T_j

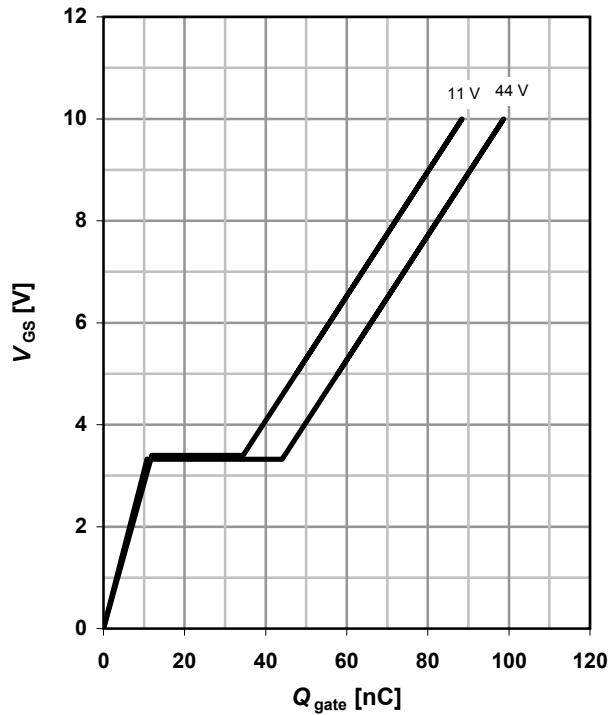


13 Typical avalanche energy

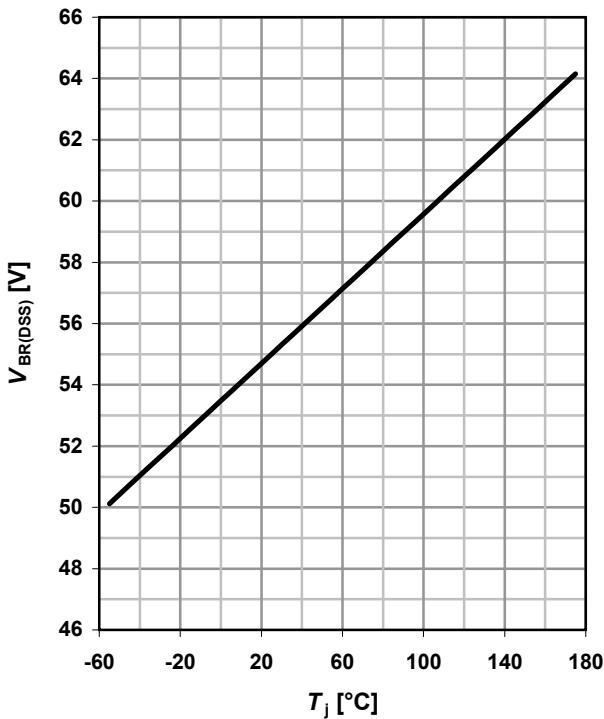
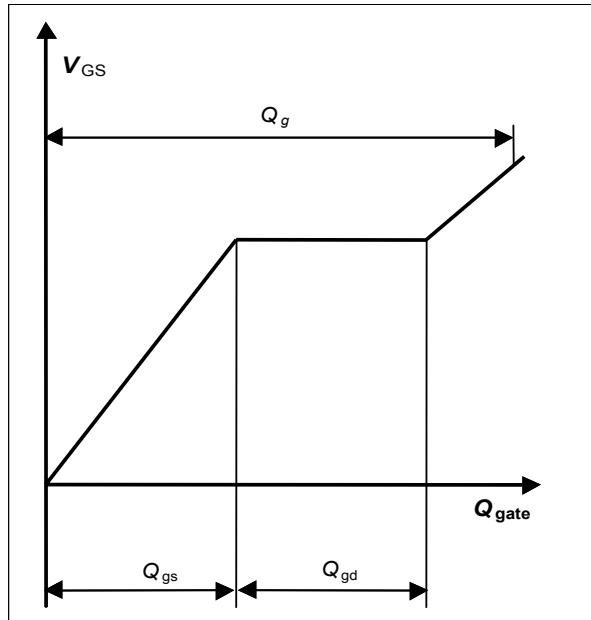
$$E_{AS} = f(T_j)$$

 parameter: I_D

14 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 80\text{ A pulsed}$$


15 Typ. drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 1\text{ mA}$$


16 Gate charge waveforms


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